

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/507,155	HAYS, JEFFREY C	
Examiner	Art Unit	
Gerald Gauthier	2645	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	2/10/2006	GG		
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